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| Notice of References Cited | Application/Control No. 10/051,374 | Applicant(s)/Patent Under Reexamination DEMUTH ET AL. | |
| | Examiner Marc Jimenez | Art Unit 3726 | Page 1 of 1 |

U.S. PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Name | Classification |
|---|---|--|-----------------|------------------|----------------|
| | A | US-5243842 | 09-1993 | Kobayashi et al. | 29/890.053 |
| | B | US-4503693 | 03-1985 | Larikka | 72/71 |
| | C | US-5737952 | 04-1998 | Baumann et al. | 72/55 |
| | D | US-2002/0029474 A1 | 03-2002 | Mitsukawa et al. | 29/890.03 |
| | E | US-5898996 | 05-1999 | Buchanan et al. | 29/890.052 |
| | F | US- | | | |
| | G | US- | | | |
| | H | US- | | | |
| | I | US- | | | |
| | J | US- | | | |
| | K | US- | | | |
| | L | US- | | | |
| | M | US- | | | |

FOREIGN PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Country | Name | Classification |
|---|---|--|-----------------|---------|--------------|----------------|
| | N | JP 355122627 A | 09-1980 | Japan | Imoto et al. | 29/890.148 |
| | O | | | | | |
| | P | | | | | |
| | Q | | | | | |
| | R | | | | | |
| | S | | | | | |
| | T | | | | | |

NON-PATENT DOCUMENTS

| * | | Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) |
|---|---|---|
| | U | |
| | V | |
| | W | |
| | X | |

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